

Terahertz ellipsometry using electron-beam based sources

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Our message

- THz ellipsometry opens a new pathways for the investigation of the properties complex optical materials needed as building blocks for next generation nanoelectronics

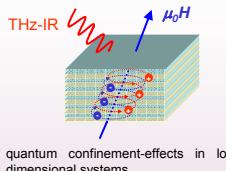
- in combination with external magnetic fields THz generalized ellipsometry is a powerful tool to determine free charge carrier properties and study quantum confinement effects in semiconductors and semimetals

- electron beam based sources are readily available (Synchrotron radiation, Smith-Purcell radiation) and offer sufficient radiation in the THz frequency domain

New THz materials preparation and analysis Center at UNL: TheMPAC

Motivation: THz spectroscopic ellipsometry

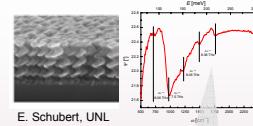
2D Semiconductor & Semimetal



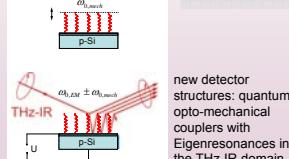
Generalized ellipsometry in combination with external magnetic fields:

- Semiconductors: unbound charge carrier resonances in spatially confined structures in the THz frequency domain
- Highly oriented pyrolytic graphite: Landau level transitions, electron and hole contributions

Complex metamaterials



resonances in a sculptured Al thin Film on Si



3D Nanostructure Networks

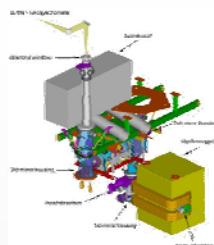


- future nanoelectronics will be assembled from nano-sized thin film structures and metamaterials
- new physical phenomena in these building blocks like quantum confinement and surface effects will alter the physical properties and need to be studied

optical metrology tools needed
optical and mechanical Eigenresonances of these material fall in the THz domain

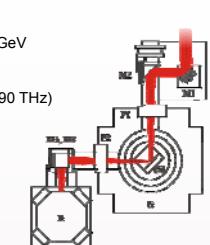
Synchrotron radiation

IRIS-beam line at BESSY II



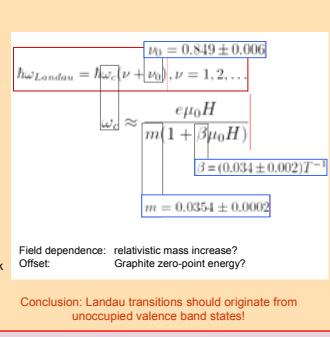
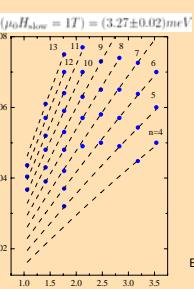
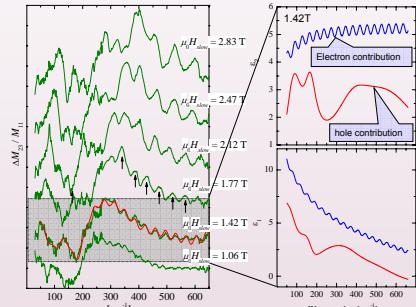
W.B. Peatman and U. Schade, Rev. Scie. Inst. 72, 1620 (2001)
U. Schade et al., Rev. Scie. Inst. 73, 1563 (2002)

Experimental setup

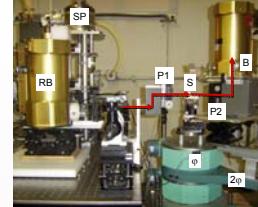


T. Hofmann et al., Rev. Scie. Inst. 77, 63902 (2006)

Highly oriented pyrolytic graphite



Smith-Purcell effect



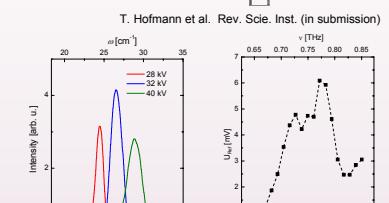
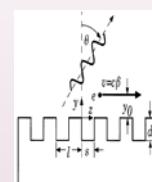
Smith-Purcell Source:

- electron energy: 20-38 keV
- grating type: rectangular Cu-grating (25 μm wide, 100 μm deep slots)

Electromagnetic radiation is emitted if an electron beam passes a periodic metal grating:

$$\lambda = \frac{L}{|n|} \left(\frac{1}{\beta c} - \sin \theta \right)$$

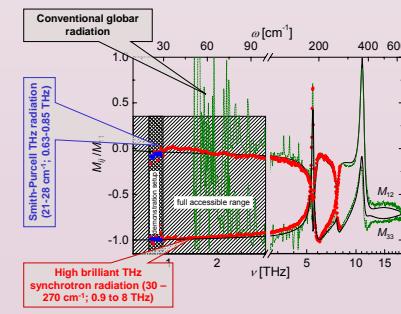
λ – output wavelength
 βc – electron velocity
 θ – emission angle



typical output intensity spectra and signal level at the reference Si-Bolometer; the source is operated below the threshold to superradiant emission

Zn_{0.87}Mn_{0.13}Se

ZnMnSe – a diluted magnetic semiconductor is employed as an example system



First optical constants for ZnMnSe in the THz domain!

